Product data sheet

## 1. Product profile

### 1.1 General description

NPN silicon microwave transistor for high speed, medium power applications in a plastic, 3-pin SOT89 package.

The BFU590Q is part of the BFU5 family of transistors, suitable for small signal to medium power applications up to 2 GHz.

### 1.2 Features and benefits

- Medium power, high linearity, high breakdown voltage RF transistor
- AEC-Q101 qualified
- Maximum stable gain 11 dB at 900 MHz
- P<sub>L(1dB)</sub> 22 dBm at 900 MHz
- 8 GHz f<sub>T</sub> silicon technology

## 1.3 Applications

- Automotive applications
- Broadband amplifiers
- Medium power amplifiers (500 mW at a frequency of 433 MHz or 866 MHz)
- Large signal amplifiers for ISM applications

#### 1.4 Quick reference data

Table 1. Quick reference data

T<sub>amb</sub> = 25 °C unless otherwise specified

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$V_{CB}$	collector-base voltage	open emitter	-	-	24	V
$V_{CE}$	collector-emitter voltage	open base	-	-	12	V
		shorted base	-	-	24	V
$V_{EB}$	emitter-base voltage	open collector	-	-	2	V
I <sub>C</sub>	collector current		-	80	200	mA
P <sub>tot</sub>	total power dissipation	$T_{sp} \le 90  ^{\circ}C$	-	-	2000	mW
h <sub>FE</sub>	DC current gain	I <sub>C</sub> = 80 mA; V <sub>CE</sub> = 8 V	60	95	130	
C <sub>c</sub>	collector capacitance	V <sub>CB</sub> = 8 V; f = 1 MHz	-	2.0	-	pF
f <sub>T</sub>	transition frequency	I <sub>C</sub> = 80 mA; V <sub>CE</sub> = 8 V; f = 900 MHz	-	8.0	-	GHz



#### NPN wideband silicon RF transistor

Table 1. Quick reference data ...continued

T<sub>amb</sub> = 25 °C unless otherwise specified

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
G <sub>p(max)</sub>	maximum power gain	$I_C = 80 \text{ mA}; V_{CE} = 8 \text{ V}; f = 900 \text{ MHz}$	-	11	-	dB
P <sub>L(1dB)</sub>	output power at 1 dB gain compression	$I_C$ = 80 mA; $V_{CE}$ = 8 V; $Z_S$ = $Z_L$ = 50 $\Omega$ ; f = 900 MHz	-	22	-	dBm

- [1]  $T_{sp}$  is the temperature at the solder point of the collector lead.
- [2] If K > 1 then  $G_{p(max)}$  is the maximum power gain. If K < 1 then  $G_{p(max)} = MSG$ .

# 2. Pinning information

Table 2. Discrete pinning

Pin	Description	Simplified outline	Graphic symbol
1	emitter		2
2	collector		]
3	base	نادا	3—
		3 2 1	
		3 2 1	aaa-011580

# 3. Ordering information

Table 3. Ordering information

Type number	Packag	ackage					
	Name	Description	Version				
BFU590Q	-	plastic surface-mounted package; exposed die pad with good heat transfer; 3 leads	SOT89				
OM7965	-	Customer evaluation kit for BFU580Q and BFU590Q [1]	-				

- [1] The customer evaluation kit contains the following:
  - a) Unpopulated RF amplifier Printed-Circuit Board (PCB)
  - b) Unpopulated RF amplifier Printed-Circuit Board (PCB) with emitter degeneration
  - c) Four SMA connectors for fitting unpopulated Printed-Circuit Board (PCB)
  - d) BFU580Q and BFU590Q samples
  - e) USB stick with data sheets, application notes, models, S-parameter and noise files

# 4. Marking

Table 4. Marking

Type number	Marking
BFU590Q	S59

# 5. Design support

Table 5. Available design support

Download from the BFU590Q product information page on <a href="http://www.nxp.com">http://www.nxp.com</a>.

Support item	Available	Remarks
Device models for Agilent EEsof EDA ADS	yes	Based on Mextram device model.
SPICE model	yes	Based on Gummel-Poon device model.
S-parameters	yes	
Customer evaluation kit	yes	See Section 3 and Section 10.
Solder pattern	yes	
Application notes	yes	See Section 10.1 and Section 10.2.

# 6. Limiting values

Table 6. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
V <sub>CB</sub>	collector-base voltage	open emitter	-	30	V
$V_{CE}$	collector-emitter voltage	open base	-	16	V
		shorted base	-	30	V
V <sub>EB</sub>	emitter-base voltage	open collector	-	3	V
I <sub>C</sub>	collector current		-	300	mA
T <sub>stg</sub>	storage temperature		-65	+150	°C
V <sub>ESD</sub>	electrostatic discharge voltage	Human Body Model (HBM) According to JEDEC standard 22-A114E	-	±250	V
		Charged Device Model (CDM) According to JEDEC standard 22-C101B	-	±2	kV

# 7. Recommended operating conditions

Table 7. Characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$V_{CB}$	collector-base voltage	open emitter	-	-	24	V
$V_{CE}$	collector-emitter voltage	open base	-	-	12	V
		shorted base	-	-	24	V
$V_{EB}$	emitter-base voltage	open collector	-	-	2	V
I <sub>C</sub>	collector current		-	-	200	mA
Pi	input power	$Z_S = 50 \Omega$	-	-	20	dBm
Tj	junction temperature		-40	-	+150	°C
P <sub>tot</sub>	total power dissipation	$T_{sp} \le 90  ^{\circ}C$ [1]	-	-	2000	mW

<sup>[1]</sup>  $T_{sp}$  is the temperature at the solder point of the collector lead.

### NPN wideband silicon RF transistor

### 8. Thermal characteristics

Table 8. Thermal characteristics

Symbol	Parameter	Conditions	Тур	Unit
$R_{th(j-sp)}$	thermal resistance from junction to solder point	<u>[1]</u>	30	K/W

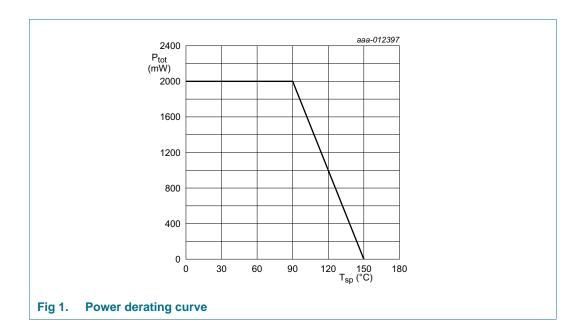
[1]  $T_{sp}$  is the temperature at the solder point of the collector lead.

 $T_{sp}$  has the following relation to the ambient temperature  $T_{amb}\!:$ 

 $T_{sp} = T_{amb} + P \times R_{th(sp-a)}$ 

With P being the power dissipation and  $R_{th(sp-a)}$  being the thermal resistance between the solder point and ambient.  $R_{th(sp-a)}$  is determined by the heat transfer properties in the application.

The heat transfer properties are set by the application board materials, the board layout and the environment e.g. housing.



### 9. Characteristics

Table 9. Characteristics

T<sub>amb</sub> = 25 °C unless otherwise specified

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$V_{(BR)CBO}$	collector-base breakdown voltage	$I_C = 100 \text{ nA}; I_E = 0 \text{ mA}$	24	-	-	V
$V_{(BR)CEO}$	collector-emitter breakdown voltage	$I_C = 150 \text{ nA}; I_B = 0 \text{ mA}$	12	-	-	V
I <sub>C</sub>	collector current		-	80	200	mA
I <sub>CBO</sub>	collector-base cut-off current	I <sub>E</sub> = 0 mA; V <sub>CB</sub> = 8 V	-	<1	-	nA
h <sub>FE</sub>	DC current gain	$I_C = 80 \text{ mA}; V_{CE} = 8 \text{ V}$	60	95	130	
C <sub>e</sub>	emitter capacitance	V <sub>EB</sub> = 0.5 V; f = 1 MHz	-	3.6	-	pF
C <sub>re</sub>	feedback capacitance	V <sub>CE</sub> = 8 V; f = 1 MHz	-	1.3	-	pF
C <sub>c</sub>	collector capacitance	V <sub>CB</sub> = 8 V; f = 1 MHz	-	2	-	pF
f <sub>T</sub>	transition frequency	I <sub>C</sub> = 50 mA; V <sub>CE</sub> = 8 V; f = 900 MHz	-	8.0	-	GHz

### **NPN** wideband silicon RF transistor

 Table 9.
 Characteristics ...continued

T<sub>amb</sub> = 25 °C unless otherwise specified

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
G <sub>p(max)</sub>	maximum power gain	f = 433 MHz; V <sub>CE</sub> = 8 V				
		I <sub>C</sub> = 10 mA	-	17	-	dB
		I <sub>C</sub> = 50 mA	-	17.5	-	dB
		I <sub>C</sub> = 80 mA	-	17.5	-	dB
		$f = 900 \text{ MHz}; V_{CE} = 8 \text{ V}$ [1]				
		I <sub>C</sub> = 10 mA	-	11	-	dB
		I <sub>C</sub> = 50 mA	-	11	-	dB
		I <sub>C</sub> = 80 mA	-	11	-	dB
		$f = 1800 \text{ MHz}; V_{CE} = 8 \text{ V}$ [1]				
		I <sub>C</sub> = 10 mA	-	6	-	dB
		I <sub>C</sub> = 50 mA	-	6.5	-	dB
		I <sub>C</sub> = 80 mA	-	6.5	-	dB
$ s_{21} ^2$	insertion power gain	f = 433 MHz; V <sub>CE</sub> = 8 V				
		I <sub>C</sub> = 10 mA	-	14.5	-	dB
		I <sub>C</sub> = 50 mA	-	16	-	dB
		I <sub>C</sub> = 80 mA	-	16	-	dB
		f = 900 MHz; V <sub>CE</sub> = 8 V				
		I <sub>C</sub> = 10 mA	-	9	-	dB
		I <sub>C</sub> = 50 mA	-	10	-	dB
		I <sub>C</sub> = 80 mA	-	10	-	dB
		f = 1800 MHz; V <sub>CE</sub> = 8 V				
		I <sub>C</sub> = 10 mA	-	3.5	-	dB
		I <sub>C</sub> = 50 mA	-	4.5	-	dB
		I <sub>C</sub> = 80 mA	-	4.5	-	dB
P <sub>L(1dB)</sub>	output power at 1 dB gain compression	$f = 433 \text{ MHz}; V_{CE} = 8 \text{ V}; Z_{S} = Z_{L} = 50 \Omega$				
		I <sub>C</sub> = 50 mA	-	20.5	-	dBm
		I <sub>C</sub> = 80 mA	-	23	-	dBm
		$f = 900 \text{ MHz}; V_{CE} = 8 \text{ V}; Z_{S} = Z_{L} = 50 \Omega$				
		I <sub>C</sub> = 50 mA	-	20	-	dBm
		I <sub>C</sub> = 80 mA	-	22	-	dBm
		$f = 1800 \text{ MHz}$ ; $V_{CE} = 8 \text{ V}$ ; $Z_{S} = Z_{L} = 50 \Omega$				1
		I <sub>C</sub> = 50 mA	-	19.5	-	dBm
		I <sub>C</sub> = 80 mA	-	22	-	dBm

### NPN wideband silicon RF transistor

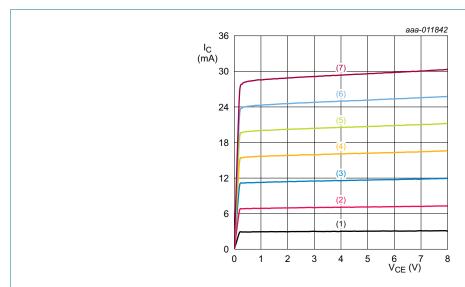
 Table 9.
 Characteristics ...continued

T<sub>amb</sub> = 25 °C unless otherwise specified

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
IP3 <sub>o</sub>	output third-order intercept point	$f_1$ = 433 MHz; $f_2$ = 434 MHz; $V_{CE}$ = 8 V; $Z_S$ = $Z_L$ = 50 $\Omega$				
		I <sub>C</sub> = 50 mA	-	30	-	dBm
		I <sub>C</sub> = 80 mA	-	32.5	-	dBm
		$f_1$ = 900 MHz; $f_2$ = 901 MHz; $V_{CE}$ = 8 V; $Z_S$ = $Z_L$ = 50 $\Omega$				
		I <sub>C</sub> = 50 mA	-	29.5	-	dBm
		I <sub>C</sub> = 80 mA	-	31.5	-	dBm
		$\begin{aligned} f_1 &= 1800 \text{ MHz};  f_2 = 1801 \text{ MHz}; \\ V_{CE} &= 8 \text{ V};  Z_S = Z_L = 50  \Omega \end{aligned}$				
		I <sub>C</sub> = 50 mA	-	29	-	dBm
		I <sub>C</sub> = 80 mA	-	31.5	-	dBm

[1] If K > 1 then  $G_{p(max)}$  is the maximum power gain. If K < 1 then  $G_{p(max)} = MSG$ .

## 9.1 Graphs

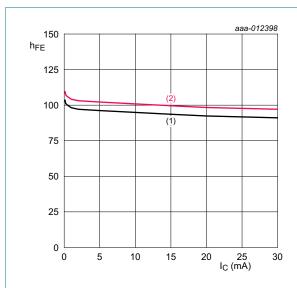


 $T_{amb} = 25 \, ^{\circ}C.$ 

- (1)  $I_B = 25 \mu A$
- (2)  $I_B = 75 \mu A$
- (3)  $I_B = 125 \mu A$
- (4)  $I_B = 175 \mu A$
- (5)  $I_B = 225 \mu A$
- (6)  $I_B = 275 \mu A$
- (7)  $I_B = 325 \mu A$

Fig 2. Collector current as a function of collector-emitter voltage; typical values

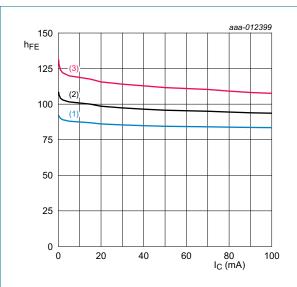
### NPN wideband silicon RF transistor



$$T_{amb} = 25 \, ^{\circ}C.$$

- (1)  $V_{CE} = 3.0 \text{ V}$
- (2)  $V_{CE} = 8.0 \text{ V}$

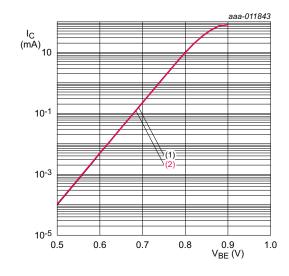
Fig 3. DC current gain as a function of collector current; typical values



$$V_{CE} = 8 V.$$

- (1)  $T_{amb} = -40 \, ^{\circ}C$
- (2)  $T_{amb} = +25 \, ^{\circ}C$
- (3)  $T_{amb} = +125 \, ^{\circ}C$

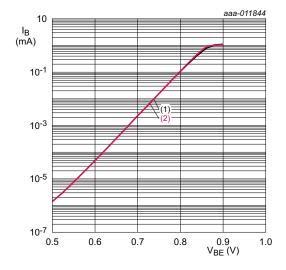
Fig 4. DC current gain as a function of collector current; typical values



 $T_{amb} = 25 \, ^{\circ}C.$ 

- (1)  $V_{CE} = 3.0 \text{ V}$
- (2)  $V_{CE} = 8.0 \text{ V}$

Fig 5. Collector current as a function of base-emitter voltage; typical values

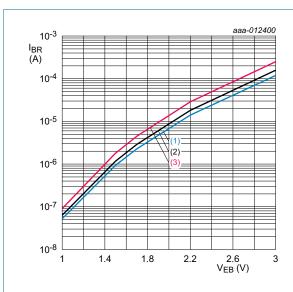


 $T_{amb} = 25 \, ^{\circ}C$ .

- (1)  $V_{CE} = 3.0 \text{ V}$
- (2)  $V_{CE} = 8.0 \text{ V}$

Fig 6. Base current as a function of base-emitter voltage; typical values

### NPN wideband silicon RF transistor



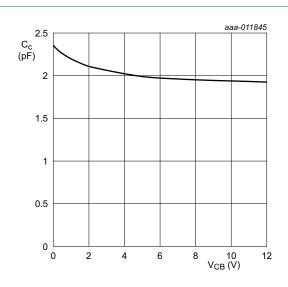
 $V_{CE} = 3 \text{ V}.$ 

(1) 
$$T_{amb} = -40 \, ^{\circ}C$$

(2) 
$$T_{amb} = +25 \, ^{\circ}C$$

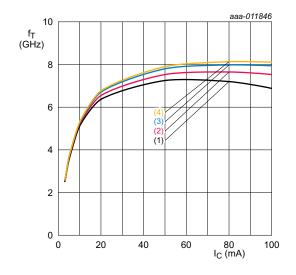
(3)  $T_{amb} = +125 \, ^{\circ}C$ 

Fig 7. Reverse base current as a function of emitter-base voltage; typical values



 $I_C = 0$  mA; f = 1 MHz;  $T_{amb} = 25$  °C.

Fig 8. Collector capacitance as a function of collector-base voltage; typical values



 $T_{amb} = 25 \, ^{\circ}C.$ 

(1) 
$$V_{CE} = 3.3 \text{ V}$$

(2) 
$$V_{CE} = 5.0 \text{ V}$$

(3) 
$$V_{CE} = 8.0 \text{ V}$$

(4) 
$$V_{CE} = 12.0 \text{ V}$$

Fig 9. Transition frequency as a function of collector current; typical values

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#### NPN wideband silicon RF transistor

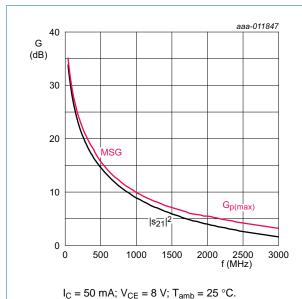
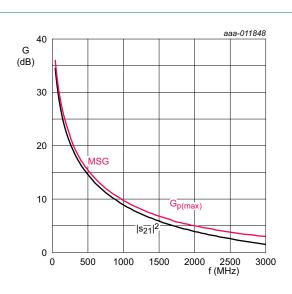
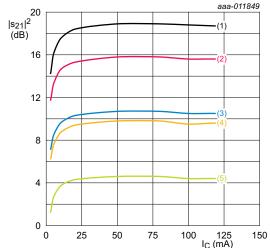


Fig 10. Gain as a function of frequency; typical values



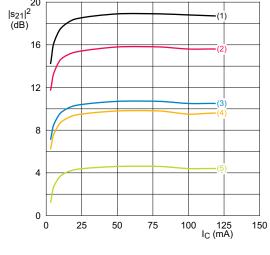
 $I_C$  = 80 mA;  $V_{CE}$  = 8 V;  $T_{amb}$  = 25 °C.

Fig 11. Gain as a function of frequency; typical values



 $V_{CE} = 8 \text{ V}$ ;  $T_{amb} = 25 \, ^{\circ}\text{C}$ .

- (1) f = 300 MHz
- (2) f = 433 MHz
- (3) f = 800 MHz
- (4) f = 900 MHz
- f = 1800 MHz



(1) f = 300 MHz

25

20

15

10

5

0

0

25

 $G_{p(max)} = MSG.$ 

50

 $V_{CE} = 8 \text{ V}$ ;  $T_{amb} = 25 \, ^{\circ}\text{C}$ .

75

100

If K > 1 then  $G_{p(max)} = maximum$  power gain. If K < 1 then

125 I<sub>C</sub> (mA)

150

G<sub>p(max)</sub> (dB)

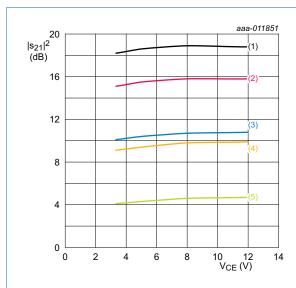
- (2) f = 433 MHz
- (3) f = 800 MHz
- (4) f = 900 MHz

Fig 12. Insertion power gain as a function of collector current; typical values



aaa-011850

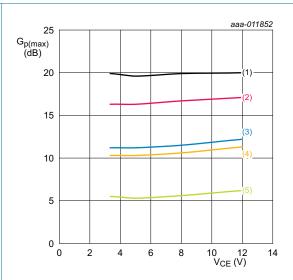
### NPN wideband silicon RF transistor



 $I_C$  = 50 mA;  $T_{amb}$  = 25 °C.

- (1) f = 300 MHz
- (2) f = 433 MHz
- (3) f = 800 MHz
- (4) f = 900 MHz
- (5) f = 1800 MHz

Fig 14. Insertion power gain as a function of collector-emitter voltage; typical values



 $I_C$  = 80 mA;  $T_{amb}$  = 25 °C.

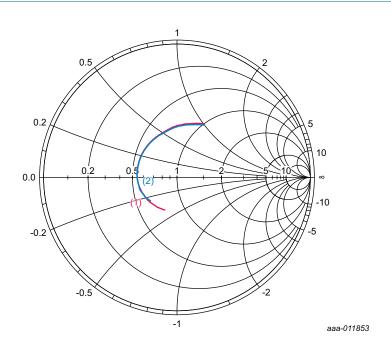
If K >1 then  $G_{p(max)}$  = maximum power gain. If K < 1 then  $G_{p(max)}$  = MSG.

- (1) f = 300 MHz
- (2) f = 433 MHz
- (3) f = 800 MHz
- (4) f = 900 MHz
- (5) f = 1800 MHz

Fig 15. Maximum power gain as a function of collector-emitter voltage; typical values

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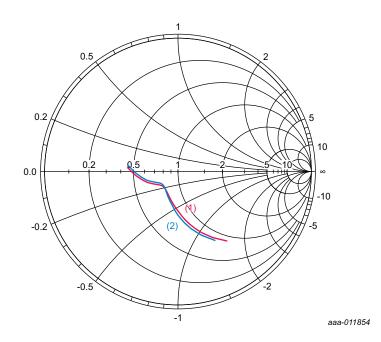
### NPN wideband silicon RF transistor



 $V_{CE} = 8~V;~40~MHz \leq f \leq 3~GHz.$ 

- (1)  $I_C = 50 \text{ mA}$
- (2)  $I_C = 80 \text{ mA}$

Fig 16. Input reflection coefficient (s<sub>11</sub>); typical values



 $V_{CE} = 8~V;~40~MHz \leq f \leq 3~GHz.$ 

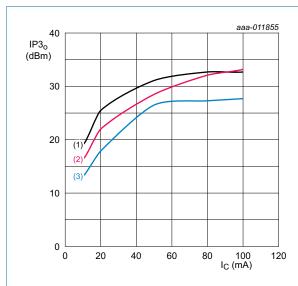
- (1)  $I_C = 50 \text{ mA}$
- (2)  $I_C = 80 \text{ mA}$

Fig 17. Output reflection coefficient  $(s_{22})$ ; typical values

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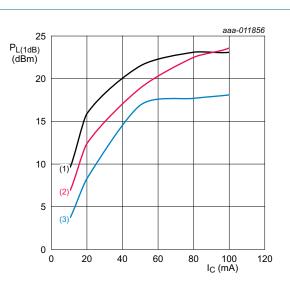
#### NPN wideband silicon RF transistor



 $V_{CE} = 8 \text{ V}; T_{amb} = 25 ^{\circ}\text{C}.$ 

- (1)  $f_1 = 433 \text{ MHz}$ ;  $f_2 = 434 \text{ MHz}$
- (2)  $f_1 = 900 \text{ MHz}$ ;  $f_2 = 901 \text{ MHz}$
- (3)  $f_1 = 1800 \text{ MHz}$ ;  $f_2 = 1801 \text{ MHz}$

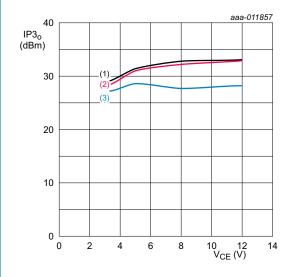
Fig 18. Output third-order intercept point as a function of collector current; typical values



 $V_{CE} = 8 \text{ V}; T_{amb} = 25 \,^{\circ}\text{C}.$ 

- (1) f = 433 MHz
- (2) f = 900 MHz
- (3) f = 1800 MHz

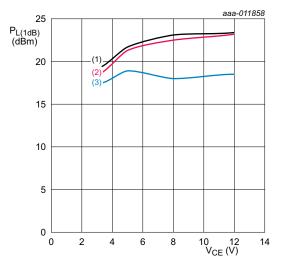
Fig 19. Output power at 1 dB gain compression as a function of collector current; typical values



 $I_C = 80 \text{ mA}$ ;  $T_{amb} = 25 \, ^{\circ}\text{C}$ .

- (1)  $f_1 = 433 \text{ MHz}$ ;  $f_2 = 434 \text{ MHz}$
- (2)  $f_1 = 900 \text{ MHz}$ ;  $f_2 = 901 \text{ MHz}$
- (3)  $f_1 = 1800 \text{ MHz}$ ;  $f_2 = 1801 \text{ MHz}$

Fig 20. Output third-order intercept point as a function of collector-emitter voltage; typical values



 $I_C = 80 \text{ mA}; T_{amb} = 25 \, ^{\circ}\text{C}.$ 

- (1) f = 433 MHz
- (2) f = 900 MHz
- (3) f = 1800 MHz

Fig 21. Output power at 1 dB gain compression as a function of collector-emitter voltage; typical values

# 10. Application information

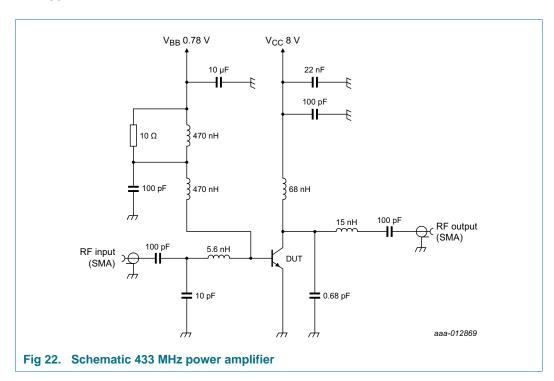
More information about the following application example can be found in the application notes. See Section 5 "Design support".

The following application example can be implemented using the evaluation kit. See Section 3 "Ordering information" for the order type number.

The following application example can be simulated using the simulation package. See Section 5 "Design support".

### 10.1 Application example: 433 MHz PA

More detailed information of the application example can be found in the application note: *AN11504.* 



Remark: fine tuning of components maybe required depending on PCB parasitics.

Table 10. Application performance data at 433 MHz

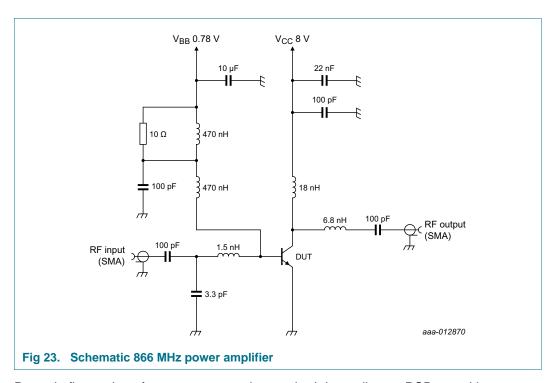
 $I_{CC} = 100 \text{ mA}; V_{CC} = 8 \text{ V}$ 

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$ s_{21} ^2$	insertion power gain		-	15	-	dB
$ s_{11} ^2$	input return loss		-	-7	-	dB
P <sub>L(1dB)</sub>	output power at 1 dB gain compression		-	26	-	dBm
ης	collector efficiency		-	60	-	%

### NPN wideband silicon RF transistor

## 10.2 Application example: 866 MHz PA

More detailed information of the application example can be found in the application note: *AN11502*.



Remark: fine tuning of components maybe required depending on PCB parasitics.

Table 11. Application performance data at 866 MHz

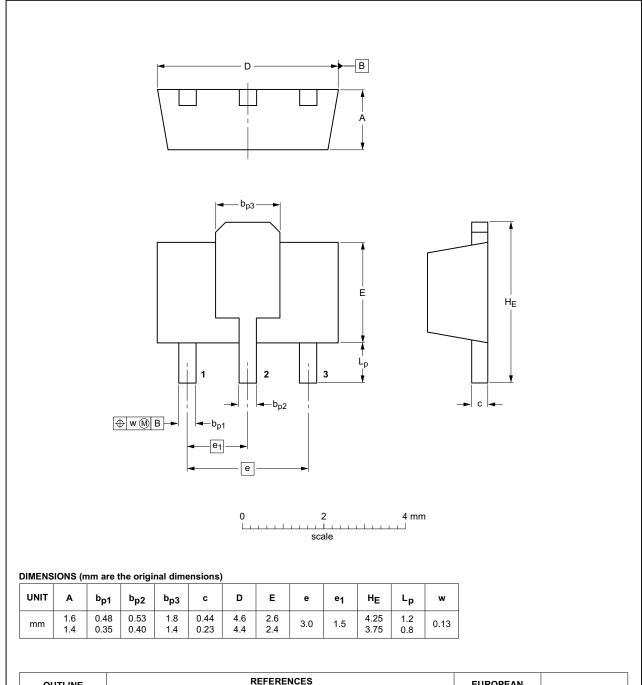
 $I_{CC} = 100 \text{ mA}; V_{CC} = 8 \text{ V}$ 

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$ s_{21} ^2$	insertion power gain		-	10	-	dB
$ s_{11} ^2$	input return loss		-	-12	-	dB
P <sub>L(1dB)</sub>	output power at 1 dB gain compression		-	27	-	dBm
ης	collector efficiency		-	55	-	%

# 11. Package outline

### Plastic surface-mounted package; exposed die pad for good heat transfer; 3 leads

SOT89



OUTLINE		REFER	RENCES		ISSUE DATE		
VERSION	IEC	JEDEC	JEITA		PROJECTION	ISSUE DATE	
SOT89		TO-243	SC-62			<del>06-03-16</del> 06-08-29	

Fig 24. Package outline SOT89

### NPN wideband silicon RF transistor

# 12. Handling information

### CAUTION



This device is sensitive to ElectroStatic Discharge (ESD). Observe precautions for handling electrostatic sensitive devices.

Such precautions are described in the ANSI/ESD S20.20, IEC/ST 61340-5, JESD625-A or equivalent standards.

# 13. Abbreviations

Table 12. Abbreviations

Acronym	Description
AEC	Automotive Electronics Council
ISM	Industrial, Scientific and Medical
LNA	Low-Noise Amplifier
MSG	Maximum Stable Gain
NPN	Negative-Positive-Negative
PA	Power Amplifier
SMA	SubMiniature version A

# 14. Revision history

Table 13. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
BFU590Q v.1	20140428	Product data sheet	-	-

#### NPN wideband silicon RF transistor

## 15. Legal information

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Document status[1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
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Product [short] data sheet	Production	This document contains the product specification.

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#### NPN wideband silicon RF transistor

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### NPN wideband silicon RF transistor

## 17. Contents

1	Product profile
1.1	General description 1
1.2	Features and benefits 1
1.3	Applications 1
1.4	Quick reference data 1
2	Pinning information 2
3	Ordering information 2
4	Marking 2
5	Design support 3
6	Limiting values 3
7	Recommended operating conditions 3
8	Thermal characteristics 4
9	Characteristics 4
9.1	Graphs 6
10	Application information
10.1	Application example: 433 MHz PA 13
10.2	Application example: 866 MHz PA 14
11	Package outline
12	Handling information 16
13	Abbreviations
14	Revision history 16
15	Legal information
15.1	Data sheet status
15.2	Definitions
15.3	Disclaimers
15.4	Trademarks18
16	Contact information 18
17	Contents

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